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| Notice of References Cited | Application/Control No. 10/063,055 | Applicant(s)/Patent Under Reexamination HUANG ET AL. | |
| | Examiner Cheukfan Lee | Art Unit 2622 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-6,450,475 | 09-2002 | Tsai et al. | 248/650 |
| | B | US-6,169,622 | 01-2001 | Tsai et al. | 359/210 |
| | C | US-6,075,242 | 06-2000 | Tsai et al. | 250/234 |
| | D | US-6,376,835 | 04-2002 | Tsai, Jenn-Tsair | 250/234 |
| | E | US-5,838,540 | 11-1998 | Wen-Shyong, Chang | 361/686 |
| | F | US-6,640,082 | 10-2003 | Mitomi, Yuuichi | 399/374 |
| | G | US-6,055,070 | 04-2000 | Kang, Sung-Wook | 358/497 |
| | H | US-6,012,697 | 01-2000 | Ohtomo et al. | 248/476 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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